

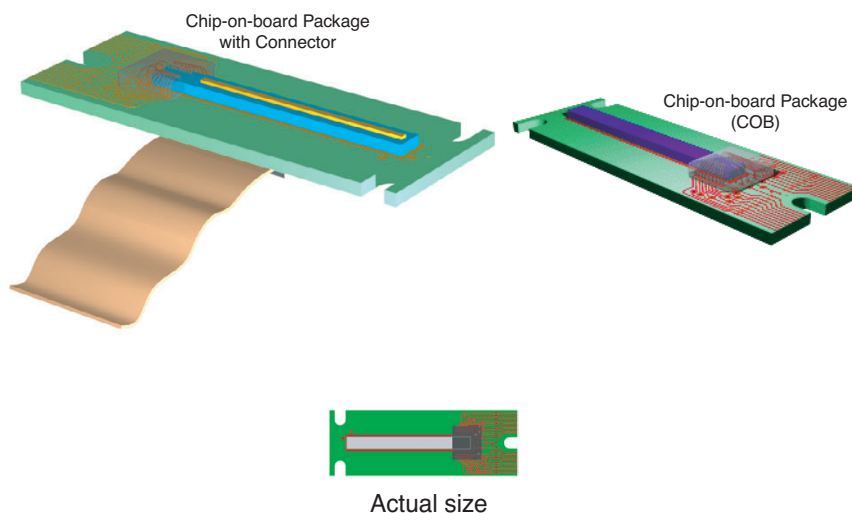
Features

- Sensitive Layer Over a $0.35\ \mu\text{m}$ CMOS Array
- Image Zone: $0.4\ \text{x}\ 14\ \text{mm} = 0.02''\ \text{x}\ 0.55''$
- Image Array: $8\ \text{x}\ 280 = 2240$ pixels
- Pixel Pitch: $50\ \mu\text{m}\ \text{x}\ 50\ \mu\text{m} = 500\ \text{dpi}$
- Pixel Clock: up to 2 MHz Enabling up to 1780 Frames per Second
- Die Size: $1.64\ \text{x}\ 17.46\ \text{mm}$
- Operating Voltage: 3V to 3.6V
- Naturally Protected Against ESD: $> 16\ \text{kV}$ Air Discharge
- Power Consumption: 20 mW at 3.3V, 1 MHz, 25°C
- Operating Temperature Range: -40°C to $+85^\circ\text{C}$
- Resistant to Abrasion: > 1 Million Finger Sweeps
- Chip-on-Board (COB), Chip-on-Board (COB) with Connector, or 20-lead Ceramic DIP Available for Development, with Specific Protective Layer

Applications

- PDA (Access Control, Data Protection)
- Cellular Phones, SmartPhones (Access e-business)
- Notebook, PC-add on (Access Control, e-business)
- PIN Code Replacement
- Automated Teller Machines, POS
- Building Access
- Electronic Keys (Cars, Home,...)
- Portable Fingerprint Imaging for Law Enforcement
- TV Access

Figure 1. FingerChip® Packages



**Thermal
Fingerprint
Sensor with
0.4 mm x 14 mm
(0.02" x 0.55")
Sensing Area
and
Digital Output
(On-chip ADC)**

**AT77C102B
FingerChip®**



Rev. 5364A-BIOM-11/03





Table 1. Pin Description for Chip-on-Board Package: AT77C102B-CB01I

| Pin Number | Name | Type |
|------------|------|----------------|
| 1 | GND | GND |
| 2 | AVE | Analog output |
| 3 | AVO | Analog output |
| 4 | TPP | Power |
| 5 | TPE | Digital input |
| 6 | VCC | Power |
| 7 | GND | GND |
| 8 | RST | Digital input |
| 9 | PCLK | Digital input |
| 10 | OE | Digital input |
| 11 | ACKN | Digital output |
| 12 | De0 | Digital output |
| 13 | Do0 | Digital output |
| 14 | De1 | Digital output |
| 15 | Do1 | Digital output |
| 16 | De2 | Digital output |
| 17 | Do2 | Digital output |
| 18 | De3 | Digital output |
| 19 | Do3 | Digital output |
| 20 | FPL | GND |
| 21 | GND | GND |

The die attach is connected to pins 1, 7 and 21, and must be grounded. The FPL pin must be grounded.

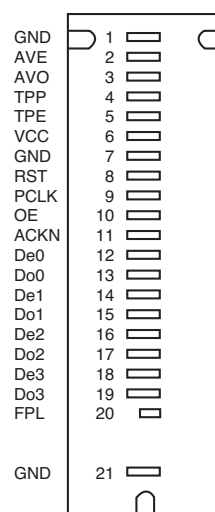


Table 2. Pin Description for COB with Connector Package: AT77C102B-CB02I⁽¹⁾

| Pin Number | Name | Type |
|------------|---------------|----------------|
| 1 | FPL | GND |
| 2 | Not connected | |
| 3 | Not connected | |
| 4 | DE3 | Digital output |
| 5 | DO3 | Digital output |
| 6 | DE2 | Digital output |
| 7 | DO2 | Digital output |
| 8 | DE1 | Digital output |
| 9 | DO1 | Digital output |
| 10 | DE0 | Digital output |
| 11 | DO0 | Digital output |
| 12 | AVE | Analog output |
| 13 | AVO | Analog output |
| 14 | TPP | Power |
| 15 | TPE | Digital input |
| 16 | VCC | Power |
| 17 | GND | GND |
| 18 | RST | Digital input |
| 19 | PCLK | Digital input |
| 20 | OE | Digital input |
| 21 | ACKN | Digital output |

Note: 1. Ref Connector: FH18-21S-0.3SHW (HIROSE).

Figure 2. COB with Flex⁽¹⁾

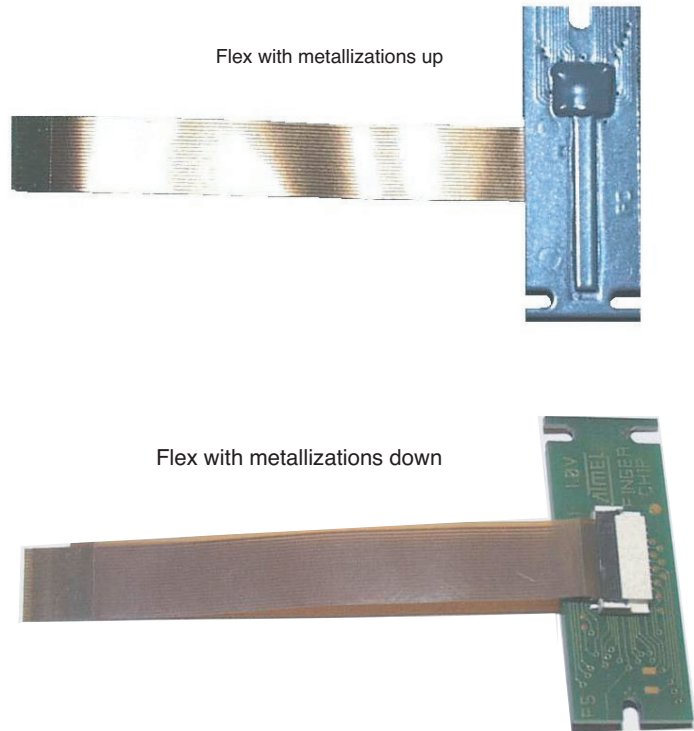
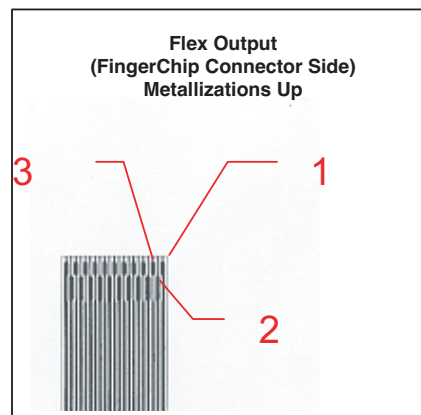


Figure 3. Flex Output Side



Note: 1. Flex is not provided by ATMEL.

Description

The AT77C102B is part of the Atmel FingerChip monolithic fingerprint sensor family for which no optics, no prism and no light source are required.

The AT77C102B is a single-chip, high-performance, low-cost sensor based on temperature physical effects for fingerprint sensing.

The AT77C102B has a linear shape, which captures a fingerprint image by sweeping the finger across the sensing area. After capturing several images, Atmel proprietary software can reconstruct a full 8-bit fingerprint image.

The AT77C102B has a small surface combined with CMOS technology, and a Chip-on-Board package assembly. These facts contribute to a low-cost device.

The device delivers a programmable number of images per second, while an integrated analog-to-digital converter delivers a digital signal adapted to interfaces such as an EPP parallel port, a USB microcontroller or directly to microprocessors. No frame grabber or glue interface is therefore necessary to send the frames. These facts make AT77C102B an easy device to include in any system for identification or verification applications.

Table 3. Absolute Maximum Ratings⁰

| Parameter | Symbol | Comments | Value | Note: Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability. |
|--|--------------------|---------------|-----------------------------|---|
| Positive supply voltage | V _{CC} | | GND to 4.6 | |
| Temperature stabilization power | TPP | | GND to 4.6 | |
| Front plane | FPL | | GND to V _{CC} +0.5 | |
| Digital input voltage | RST PCLK | | GND to V _{CC} +0.5 | |
| Storage temperature | T _{stg} | | -50 to +95 | |
| Lead temperature (soldering, 10 seconds) | T _{leads} | Do not solder | Forbidden | |

Table 4. Recommended Conditions Of Use

| Parameter | Symbol | Comments | Min | Typ | Max | Unit |
|-----------------------------|----------------------------------|------------------|----------------|------|------|----------|
| Positive supply voltage | V _{CC} | | 3V | 3.3V | 3.6V | V |
| Front plane | FPL | Must be grounded | GND | | | V |
| Digital input voltage | | | CMOS levels | | | V |
| Digital output voltage | | | CMOS levels | | | V |
| Digital load | C _L | | | | 50 | pF |
| Analog load | C _A R _A | Not connected | | | | pF kΩ |
| Operating temperature range | T _{amb} | I grade | -40°C to +85°C | | | °C |
| Maximum current on TPP | ITPP | | 0 | | 100 | mA |



Table 5. Resistance

| Parameter | Min Value | Standard Method |
|--|-----------|-----------------------------|
| ESD | | |
| On pins. HBM (Human Body Model) CMOS I/O | 2 kV | MIL-STD-883 - method 3015.7 |
| On die surface (Zapgun) Air discharge | ±16 kV | NF EN 6100-4-2 |
| Mechanical Abrasion | | |
| Number of cycles without lubricant multiply by a factor of 20 for correlation with a real finger | 200 000 | MIL E 12397B |
| Chemical Resistance | | |
| Cleaning agent, acid, grease, alcohol, diluted acetone | 4 hours | Internal method |

Table 6. Specifications

| Explanation Of Test Levels | |
|----------------------------|--|
| I | 100% production tested at +25°C |
| II | 100% production tested at +25°C, and sample tested at specified temperatures (AC testing done on sample) |
| III | Sample tested only |
| IV | Parameter is guaranteed by design and/or characterization testing |
| V | Parameter is a typical value only |
| VI | 100% production tested at temperature extremes |
| D | 100% probe tested on wafer at $T_{amb} = +25^{\circ}\text{C}$ |

| Parameter | Test Level | Min | Typ | Max | Unit |
|----------------------------------|------------|---------|-----|-----|------------|
| Resolution | IV | 50 | | | μm |
| Size | IV | 8 x 280 | | | Pixel |
| Yield: number of bad pixels | I | | | 5 | Bad pixels |
| Equivalent resistance on TPP pin | I | 20 | 30 | 47 | Ω |

Table 7. 3.3V Power supply

The following characteristics are applicable to the operating temperature $-40^{\circ}\text{C} \leq T_a \leq +85^{\circ}\text{C}$

Typical conditions are: $V_{CC} = +3.3\text{ V}$; $T_{\text{amb}} = 25^{\circ}\text{C}$; $F_{\text{PCLK}} = 1\text{ MHz}$; Duty cycle = 50%

C_{load} 120 pF on digital outputs, analog outputs disconnected unless otherwise specified

| Parameter | Symbol | Test Level | Min | Typ | Max | Unit |
|---|--------------------|------------|------|-----|----------|---------------|
| Power Requirements | | | | | | |
| Positive supply voltage | V_{CC} | | 3.0 | 3.3 | 3.6 | V |
| Active current on V_{CC} pin, 1 MHz, 25°C | I_{CC} | I | | 6 | 10 | mA |
| Active current on V_{CC} pin, $C_{\text{load}} = 0\text{ pF}$ | | IV | | 5 | 6 | mA |
| Power dissipation on V_{CC} | P_{CC} | I | | 20 | 36 | mW |
| $C_{\text{load}} = 0$ | | IV | | 17 | 22 | mW |
| Current on V_{CC} in NAP mode | I_{CCNAP} | I | | | 10 | μA |
| Analog Output | | | | | | |
| Voltage range | V_{AVx} | IV | 0 | | 2.9 | V |
| Digital Inputs | | | | | | |
| Logic compatibility | | | CMOS | | | |
| Logic "0" voltage | V_{IL} | I | 0 | | 0.8 | V |
| Logic "1" voltage | V_{IH} | I | 2.3 | | V_{CC} | V |
| Logic "0" current | I_{IL} | I | -10 | | 0 | μA |
| Logic "1" current | I_{IH} | I | 0 | | 10 | μA |
| TPE logic "0" voltage | $I_{IL\text{TPE}}$ | 1 | -10 | | 0 | μA |
| TPE logic "1" voltage | $I_{IH\text{TPE}}$ | 1 | 0 | | 100 | μA |
| Digital Outputs | | | | | | |
| Logic compatibility | | | CMOS | | | |
| Logic "0" voltage ⁽¹⁾ | V_{OL} | I | | | 0.6 | V |
| Logic "1" voltage ⁽¹⁾ | V_{OH} | I | 2.4 | | | V |

Note: 1. With $I_{OL} = 1\text{ mA}$ and $I_{OH} = -1\text{ mA}$

Table 8. Switching Performances

The following characteristics are applicable to the operating temperature $-40^{\circ}\text{C} \leq T_a \leq +85^{\circ}\text{C}$

Typical conditions are: nominal voltage; $T_{\text{amb}} = 25^{\circ}\text{C}$; $F_{\text{PCLK}} = 1 \text{ MHz}$; Duty cycle = 50%

C_{load} 120 pF on digital and analog outputs unless otherwise specified

| Parameter | Symbol | Test Level | Min | Typ | Max | Unit |
|--|--------------------|------------|-----|-----|-----|------|
| Clock frequency | f_{PCLK} | I | 0.5 | 1 | 2 | MHz |
| Clock pulse width (high) | t_{HCLK} | I | 250 | | | ns |
| Clock pulse width (low) | t_{LCLK} | I | 250 | | | ns |
| Clock setup time (high)/reset falling edge | t_{Setup} | I | | | 0 | ns |
| No data change | t_{NOOE} | IV | 100 | | | ns |
| Reset pulse width high | t_{HRST} | IV | 50 | | | ns |

Table 9. 3.3V $\pm 10\%$ Power Supply

| Parameter | Symbol | Test Level | Min | Typ | Max | Unit |
|---|----------------------|------------|-----|-----|-----|------|
| Output delay from PCLK to ACKN rising edge | t_{PLHACKN} | I | | | 145 | ns |
| Output delay from PCLK to ACKN falling edge | t_{PHLACKN} | I | | | 145 | ns |
| Output delay from PCLK to data output Dxi | t_{PDATA} | I | | | 120 | ns |
| Output delay from PCLK to analog output AVx | t_{PAVIDEO} | I | | | 250 | ns |
| Output delay from OE to data high-Z | t_{DATAZ} | IV | | 34 | | ns |
| Output delay from OE to data output | t_{ZDATA} | IV | | 47 | | ns |

Figure 4. Reset

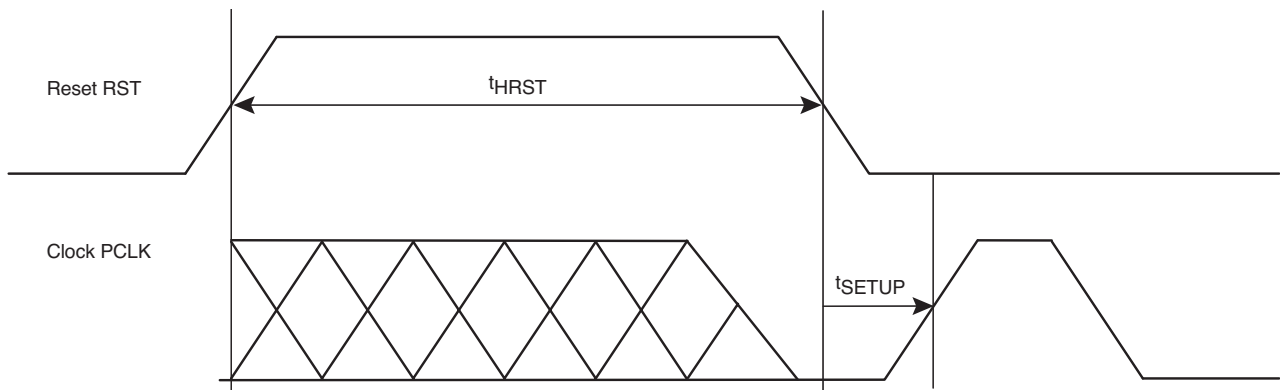


Figure 5. Read One Byte/Two Pixels

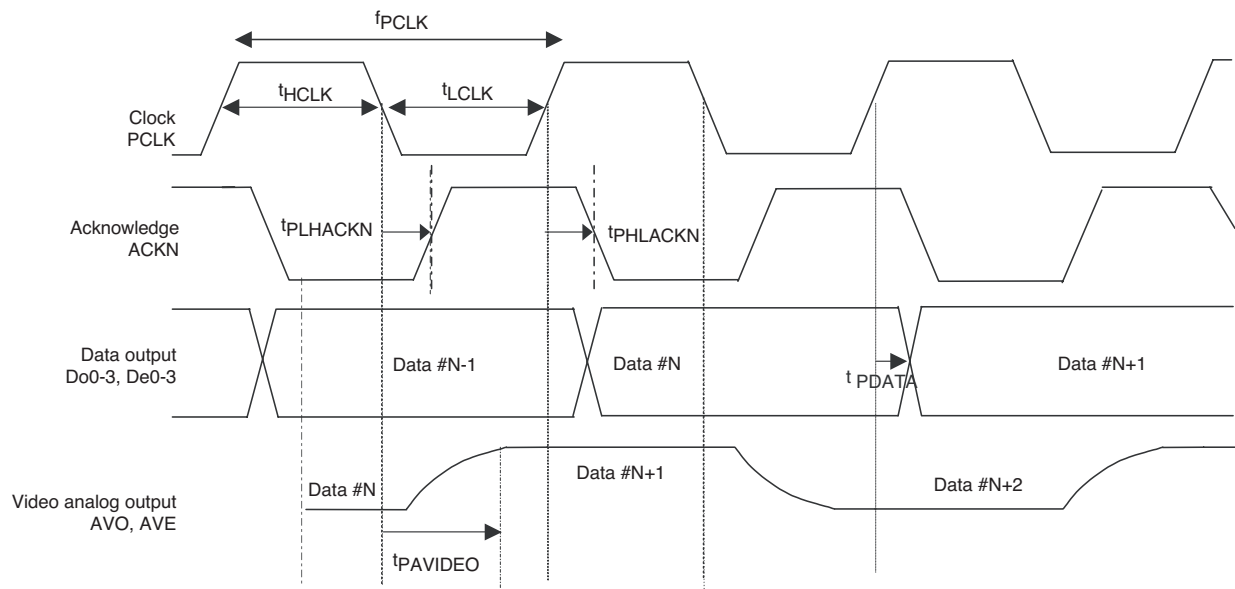


Figure 6. Output Enable

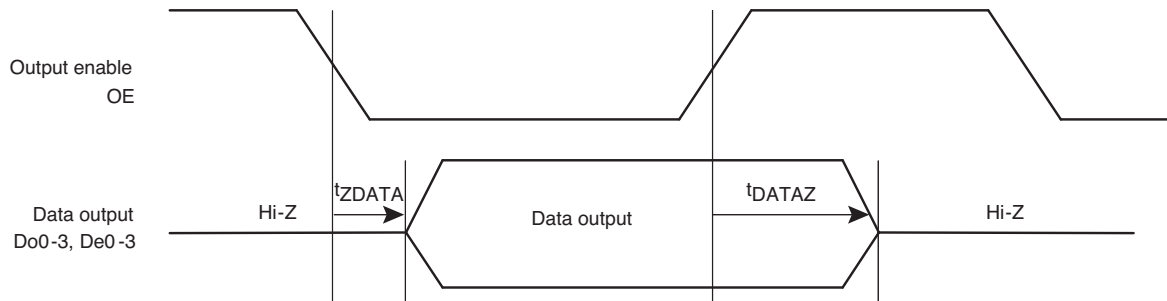
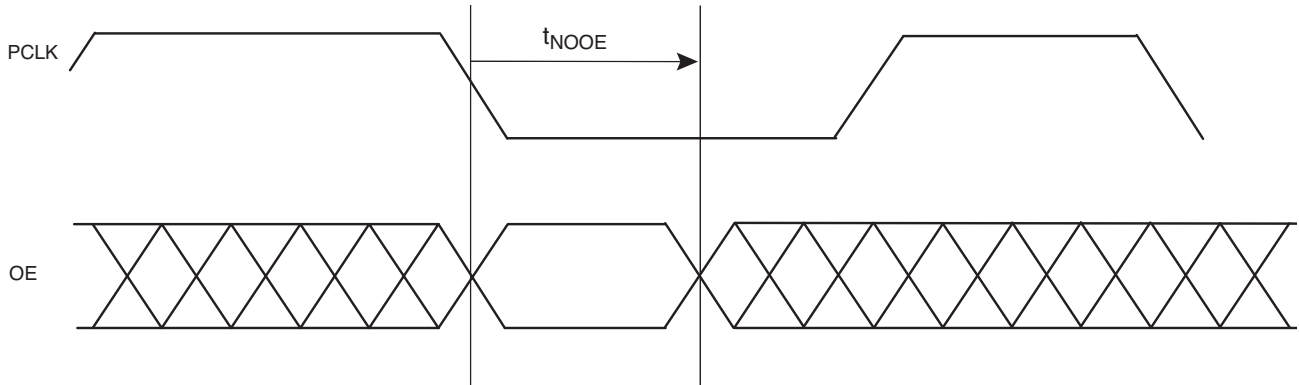
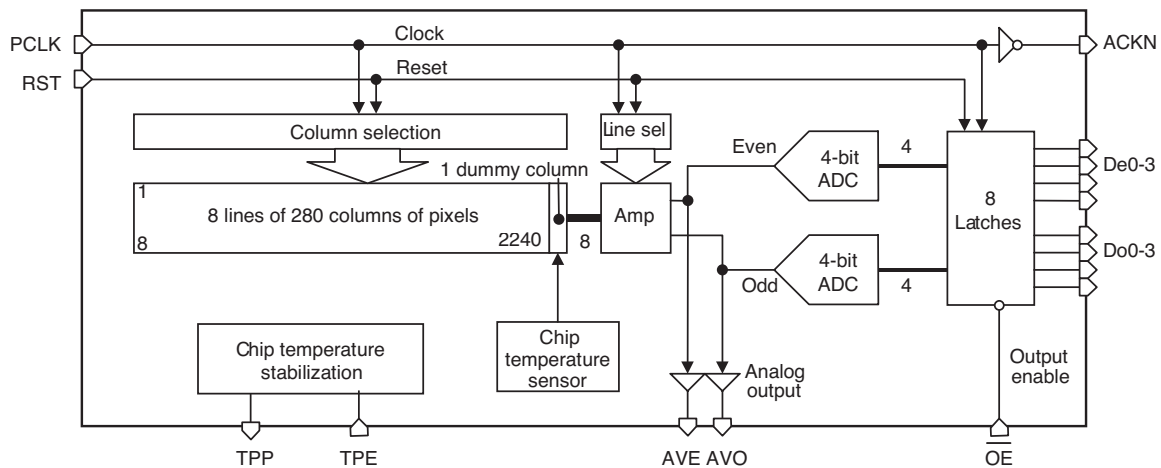


Figure 7. No Data Change



Note: OE must not change during TNOOE after the PCLK falls. This is to ensure that the output drivers of the data are not driving current, so as to reduce the noise level on the power supply.

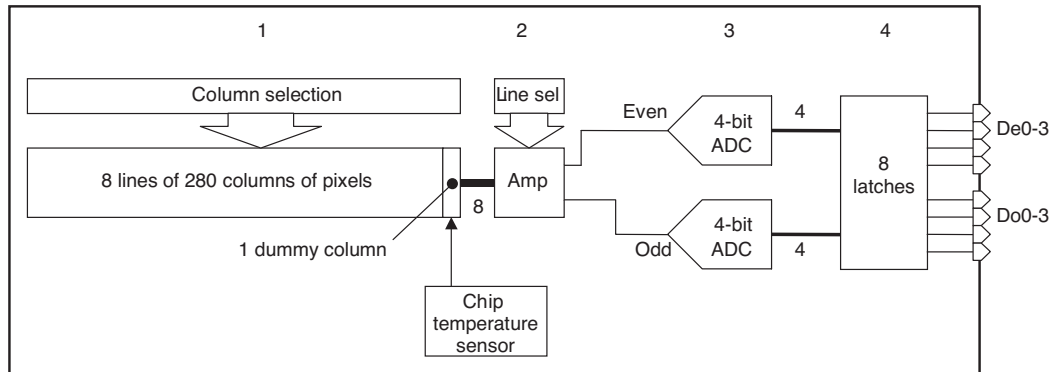
Figure 8. AT77C101B Block Diagram



Functional Description

The circuit is divided into two main sections: sensor and data conversion. One particular column among 280 plus one is selected in the sensor array (1), then each pixel of the selected column sends its electrical information to the amplifiers (2) [one per line], then two lines at a time are selected (odd and even) so that two particular pixels send their information to the input of two 4-bit analog-to-digital converters (3), so two pixels can be read for each clock pulse (4).

Figure 9. Functional Description



Sensor

Each pixel is a sensor in itself. The sensor detects a temperature difference between the beginning of an acquisition and the reading of the information: this is the integration time. The integration time begins with a reset of the pixel to a predefined initial state. Note that the integration time reset has nothing to do with the reset of the digital section.

Then, at a rate depending on the sensitivity of the pyroelectric layer, on the temperature variation between the reset and the end of the integration time, and for the duration of the integration time, electrical charges are generated at the pixel level.

Analog-to-digital Converter/ Reconstructing an 8-bit Fingerprint Image

An analog-to-digital converter (ADC) is used to convert the analog signal coming from the pixel into digital data that can be used by a processor.

As the data rate for the parallel port and the USB is in the range of 1 MB per second, and at least a rate of 500 frames per second is needed to reconstruct the image with a fair sweeping speed of the finger, two 4-bit ADCs have been used to output two pixels at a time on one byte.

Start Sequence

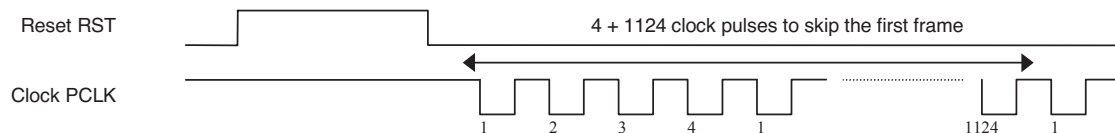
A reset is not necessary between each frame acquisition.

The start sequence must consist in:

1. Setting the RST pin to high
2. Setting the RST pin to low
3. Sending 4 clock pulses (due to pipe-line)
4. Sending clock pulses to skip the first frame

Note that after a reset it is recommended to skip the first 200 slices to stabilize the acquisition.

Figure 10. Start Sequence





Reading the Frames

A frame consists of 280 true columns plus one dummy column of eight pixels. As two pixels are output at a time, a system must send $281 \times 4 = 1124$ clock pulses to read one frame.

Reset must be low when reading the frames.

Read One Byte/Output Enable

The clock is taken into account on its falling edge and data is output on its rising edge.

For each clock pulse, after the start sequence, a new byte is output on the Do0-3 and De0-3 pins. This byte contains two pixels: 4-bit on Do0-3 (odd pixels), 4-bit on De0-3 (even pixels).

To output the data, the output enable (OE) pin must be low. When OE is high, the Do0-3 and De0-3 pins are in high-impedance state. This facilitates an easy connection to a microprocessor bus without additional circuitry since the data output can be enabled using a chip select signal. Note that the AT77C102B always sends data: there is no data exchange to switch to read/write mode.

Power Supply Noise

IMPORTANT: When a falling edge is applied on OE (that is when the Output Enable becomes active), then some current is drained from the power supply to drive the eight outputs, producing some noise. It is important to avoid such noise just after the PCLK clock's falling edge, when the pixels' information is evaluated: the timing diagram (Figure 5) and time T_{NOOE} define the interval time when the power supply must be as quiet as possible.

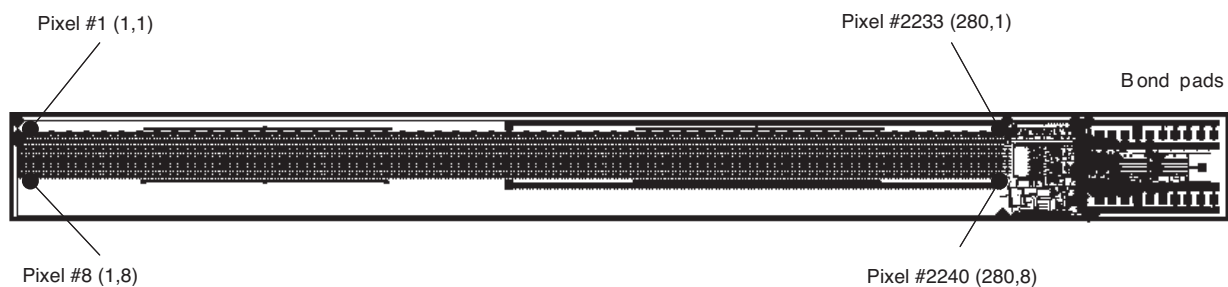
Video Output

An analog signal is also available on pins AVE and AVO. Note that video output is available one clock pulse before the corresponding digital output (one clock pipe-line delay for the analog to digital conversion).

Pixel Order

After a reset, pixel 1 is located on the upper left corner, looking at the chip with bond pads to the right. For each column of eight pixels, pixels 1, 3, 5 and 7 are output on odd data Do0-3 pins, and pixels 2, 4, 6 and 8 are output on even data De0-3 pins. The Most Significant Bit (MSB) is bit 3, and the Least Significant Bit is bit 0.

Figure 11. Pixel Order



Synchronization: The Dummy Column

A dummy column has been added to the sensor to act as a specific pattern to detect the first pixel. Therefore, 280 true columns plus one dummy column are read for each frame.

The four bytes of the dummy column contain a fixed pattern on the first two bytes, and temperature information on the last two bytes.

| Dummy Byte | Odd | Even |
|-------------------|------|------|
| Dummy Byte 1 DB1: | 111X | 0000 |
| Dummy Byte 2 DB2: | 111X | 0000 |
| Dummy Byte 3 DB3: | rrrr | nnnn |
| Dummy Byte 4 DB4: | tttt | pppp |

Note: x represents 0 or 1

The sequence 111X0000 111X0000 appears on every frame (exactly every 1124 clock pulses), so it is an easy pattern to recognize for synchronization purposes.

Thermometer

The dummy bytes DB3 and DB4 contain some internal and temperature information.

The even nibble nnnn in DB3 can be used to measure an increase or decrease of the chip's temperature, using the difference between two measures of the same physical device. The following table gives values in Kelvin.

| nnnn Decimal | nnnn Binary | Temperature differential with code 8 in Kelvin |
|-----------------|----------------|---|
| 15 | 1111 | > 11.2 |
| 14 | 1110 | 8.4 |
| 13 | 1101 | 7 |
| 12 | 1100 | 5.6 |
| 11 | 1011 | 4.2 |
| 10 | 1010 | 2.8 |
| 9 | 1001 | 1.4 |
| 8 | 1000 | 0 |
| 7 | 0111 | -1.4 |
| 6 | 0110 | -2.8 |
| 5 | 0101 | -4.2 |
| 4 | 0100 | -5.6 |
| 3 | 0011 | -7 |
| 2 | 0010 | -8.4 |
| 1 | 0001 | -11.2 |
| 0 | 0000 | < -16.8 |

For code 0 and 15, the absolute value is a minimum (saturation).



When the image contrast becomes faint because of a low temperature difference between the finger and the sensor, it is recommended to use the temperature stabilization circuitry to increase the temperature by two codes (that is from 8 to 10), so as to obtain a sensor increase of at least >1.4 Kelvin. This enables enough contrast to obtain a proper fingerprint reconstruction.

Integration Time and Clock Jitter

The AT77C102B is not very sensitive to clock jitters (clock variations). The most important requirement is a regular integration time that ensures the frame reading rate is also as regular as possible, so as to obtain consistent fingerprint slices.

If the integration time is not regular, the contrast can vary from one frame to another.

Note that it is possible to introduce some waiting time between each set of 1124 clock pulses, but the overall time of one frame read must be regular. This waiting time is generally the time needed by the processor to perform some calculation over the frame (to detect the finger, for instance).

Figure 12. Read One Frame

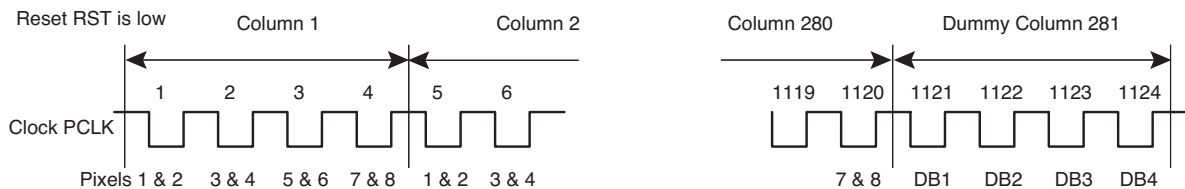
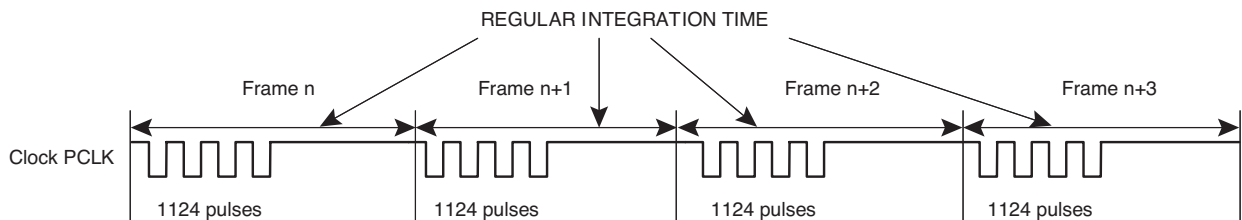


Figure 13. Regular Integration Time



Power Management

Nap Mode

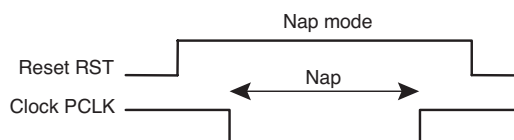
Several strategies are possible to reduce power consumption when the device is not in use.

The simplest and most efficient is to cut the power supply using external means.

A nap mode is also implemented in the AT77C102B. To activate this nap mode, you must:

1. Set the reset RST pin to high. By doing this, all analog sections of the device are internally powered down.
2. Set the clock PCLK pin to high (or low), thus stopping the entire digital section.
3. Set the TPE pin to low to stop the temperature stabilization feature.
4. Set the Output Enable OE pin to high, so that the output is forced in HiZ.

Figure 14. Nap Mode



In nap mode, all internal transistors are in shut mode. Only leakage current is drained in the power supply, generally less than the tested value.

Static Current Consumption

When the clock is stopped (set to 1) and the reset is low (set to 0), the device's analog sections drain some current, whereas, if the outputs are connected to a standard CMOS input, the digital section does not consume any current (no current is drained in the I/O). In this case the typical current value is 5 mA. This current does not depend on the voltage (it is almost the same from 3 to 3.6V).

Dynamic Current Consumption

When the clock is running, the digital sections, and particularly the outputs if they are heavily loaded, consume current. In any case, the current should be less than the testing machine (120 pF load on each I/O), and a maximum of 50 pF is recommended.

The AT77C102B, running at about 1 MHz, consumes less than 7 mA on the V_{CC} pin.

Temperature Stabilization Power Consumption (TPP Pin)

When the TPE pin is set to 1, current is drained via the TPP pin. The current is limited by the internal equivalent resistance given in Table 6 on page 6 and a possible external resistor.

Most of the time, TPE is set to 0 and no current is drained in TPP. When the image contrast becomes low because of a low temperature differential (less than 1 Kelvin), then it is recommended to set TPE to 1 for a short time so that the dissipated power in the chip elevates the temperature, allowing contrast recovery. The necessary time to increase the chip's temperature by one Kelvin depends on the dissipated power, the thermal capacity of the silicon sensor and the thermal resistance between the sensor and its surroundings. As a rule of thumb, dissipating 300 mW in the chip elevates the temperature by 1 Kelvin in one second. With the 30 Ω typical value, 300 mW is 3V applied on TPP.

Packaging: Mechanical Data

Figure 15. Product Reference: AT77C102B-CB011

Top View (all dimensions in mm)

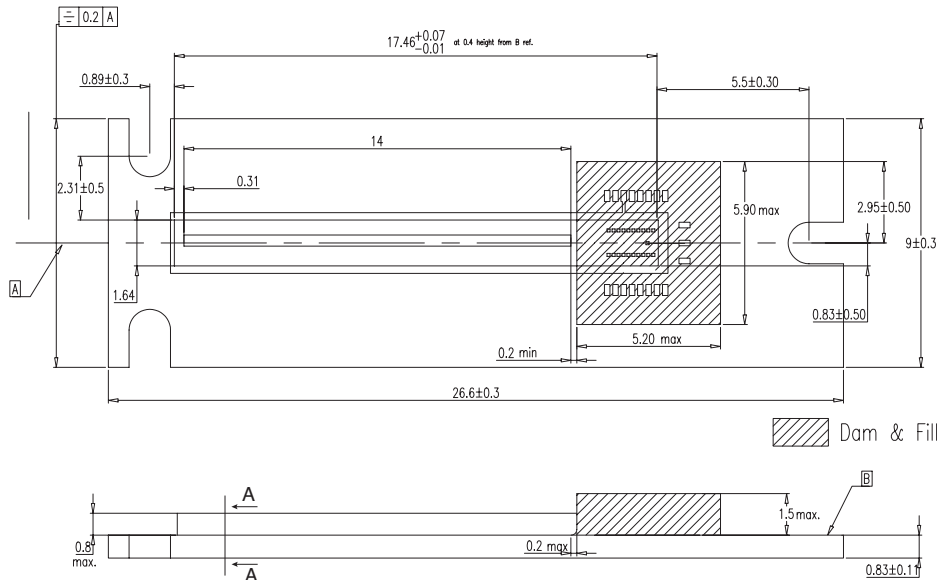


Figure 16. Product Reference: AT77C102B-CB011

Bottom View (all dimensions in mm)

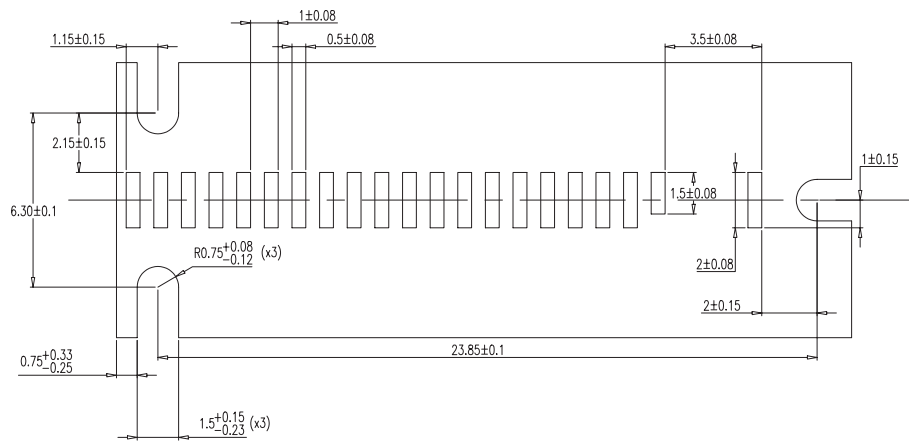
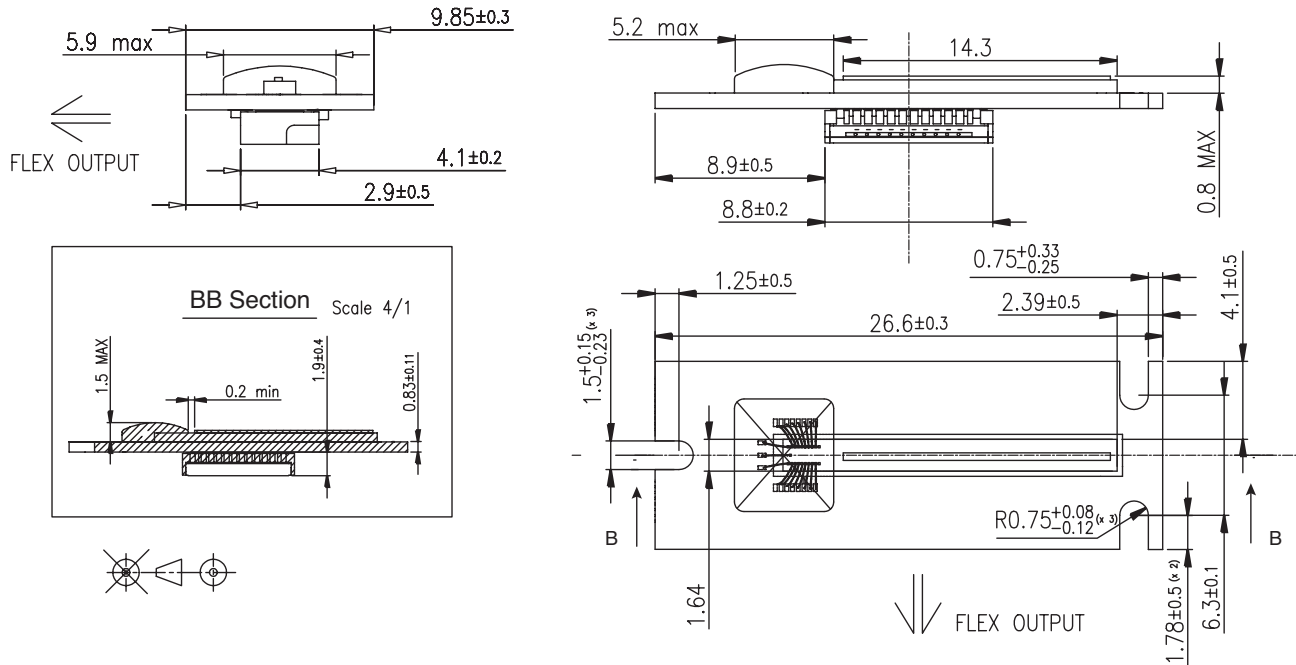


Figure 17. Product Reference: AT77C102B-CB02I



Package Information

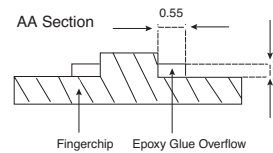
Electrical Disturbances

When looking at the fingerchip device from the top with the glob top to the right, the right edge must never be in contact with customer casing or any component to avoid electrical disturbances.

Figure 18. Epoxy Overflow

Maximum epoxy overflow width: 0.55 mm on the die edge.

Maximum epoxy overflow thickness: 0.33 mm.

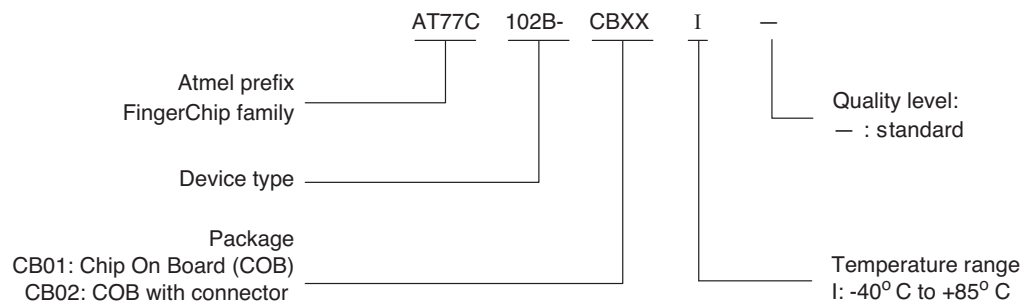


Note: Refer to Figure 15 on page 16.



Ordering Information

Package Device



Note: AT77C102B part number is interchangeable with the AT77C101B part number (except for the power supply).
To order 20 lead ceramic DIP for development, contact Atmel.



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